

TEST REPORT

REPORT NO.: CTNT2409240110201R

Model No.:

Product name:

30066TAR

Applicant:

Shenzhen Enjoy Technology Co., Ltd.

SLF UPLIFTING FACIALMICROCURRENTT LIGHT THERAPY

Test procedure: Entrustment Test



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TEST REPORT

20 CCR § 1605.3(W) Battery Chargers and Battery Charger Systems.

Report Number:	CTNT2409240110201R
Date of issue:	Oct.11,2024
Name of Testing Laboratory preparing the Report:	Shenzhen CTNT Testing Technology Co., Ltd. Room 1A106, 1/F., No.109, Lijia Road, Henggang, Henggang Street, Longgang District, Shenzhen, Guangdong, China Tel: 086-755-28680489 E-mail: admin@ctnt-cert.com Web: www.ctnt-cert.com
Applicant's name:	Shenzhen Enjoy Technology Co., Ltd.
Address:	3/F, Building 7, Jinfo Industrial Zone, Baoan District, Shenzhen, China
Manufacturer	Shenzhen Enjoy Technology Co., Ltd.
Address	3/F, Building 7, Jinfo Industrial Zone, Baoan District, Shenzhen, China
Test specification:	SS (
Standard:	20 CCR § 1605.3(W)(2) Energy Efficiency Standards for Small Battery Charger Systems.
Test procedure:	CEC: California Appliance Efficiency Regulations - Small battery charger system (20 CA ADC § 1605.3(w)(2))
Non-standard test method::	N/A
Test Report Form No	CEC-BC-TRF
Test Report Form(s) Originator :	1.0
Master TRF:	CTNT
General disclaimer:	
	relate only to the object tested. cept in full, without the written approval of the Issuing CTNT Testing t Report and its contents can be verified by contacting the CTNT,
Test item description	SLF UPLIFTING FACIALMICROCURRENTT LIGHT THERAPY
Model/Type reference	30066TAR, 30066
Trade Mark	SLF
Ratings	Input: 5V 1A Battery: 3.7V 500mAh

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	Char	Then OTHE Test	a Tochnology Co. 1td	
Laboratory Name		Shenzhen CTNT Testing Technology Co., Ltd.		
Testing location/ address:		Room 1A106, 1/F., No.109, Lijia Road, Henggang, Henggang Street, Longgang District, Shenzhen, Guangdong, China		
Tested by(Test Engineer)::		rge Tian	George Tian	
Reviewed By(Supervisor):	Olive	er Long	CHARG TECAS	
Approved by(Chief Engineer):		it Lee	CTNT	
Summary of testing:			TAPROVED	
Tests performed (name of test and test clause):		Testing location:		
Determination of the result includes consideration		Shenzhen CTNT Testing Technology Co., Ltd.		
of measurement uncertainty from the test		Room 1A106, 1/F., No.109, Lijia Road, Henggang.		
equipment and methods.				
A representative sample of the product covered		Henggang Street, Longgang District, Shenzhen,		
by this report has been tested and with the		Guangdong, China		
requirements of 20 CCR § 1605.3(W)(2) Energy		y Tel: 086-755-28680489		
Efficiency Standards for Small Battery Charger		E-mail: admin@ctnt-cert.com		
Systems.		Web: www.ctnt-cert.com		
General conditions for measurements:				
1.Test Room				
	e on o	ir speed close to the	the appliance under test of ≤ 0.5	
The tests shall be carried out in a room that ha		op daa olooda la li		
The tests shall be carried out in a room that ham m/s. The ambient temperature shall be maintain			hout the test.	
m/s. The ambient temperature shall be maintain 2.Power supply	ined a	t (20 \pm 5) °C throug		
m/s. The ambient temperature shall be maintain 2.Power supply Where this standard is referenced by an extern	ined a	t (20 \pm 5) °C throug ndard or regulation	that specifies a test voltage and	
m/s. The ambient temperature shall be maintain 2.Power supply Where this standard is referenced by an extern frequency, the test voltage and frequency so d	ined a nal sta lefined	t (20 \pm 5) °C throug ndard or regulation shall be used for a	that specifies a test voltage and Ill tests. Where the test voltage	
m/s. The ambient temperature shall be maintain 2.Power supply Where this standard is referenced by an extern frequency, the test voltage and frequency so d and frequency are not defined by an external s	ined a nal sta lefined standa	t (20 ± 5) °C throug ndard or regulation shall be used for a rd, the test voltage	that specifies a test voltage and ill tests. Where the test voltage and the test frequency shall be	
m/s. The ambient temperature shall be maintain 2.Power supply Where this standard is referenced by an extern frequency, the test voltage and frequency so d and frequency are not defined by an external so the nominal voltage and the nominal frequency	ined a nal sta lefined standa	t (20 ± 5) °C throug ndard or regulation shall be used for a rd, the test voltage	that specifies a test voltage and ill tests. Where the test voltage and the test frequency shall be	
m/s. The ambient temperature shall be maintain 2.Power supply Where this standard is referenced by an extern frequency, the test voltage and frequency so d and frequency are not defined by an external so the nominal voltage and the nominal frequency determined ±1 %.	ined a nal sta lefined standa	t (20 ± 5) °C throug ndard or regulation shall be used for a rd, the test voltage	that specifies a test voltage and ill tests. Where the test voltage and the test frequency shall be	
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